

Notice of References Cited

Application/Control No.

09/785,011

Applicant(s)/Patent Under
Reexamination
WANG ET AL.

Examiner

Kim T. Huynh

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-20020062406	05-2002	Chang et al.	710/1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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